

#### REPLACEMENT SHEET TEST CIRCUIT FOR MEASURING SENSE AMPLIFIER AND MEMORY MISMATCHES Eleyan et al. Attorney Docket: 004-30059

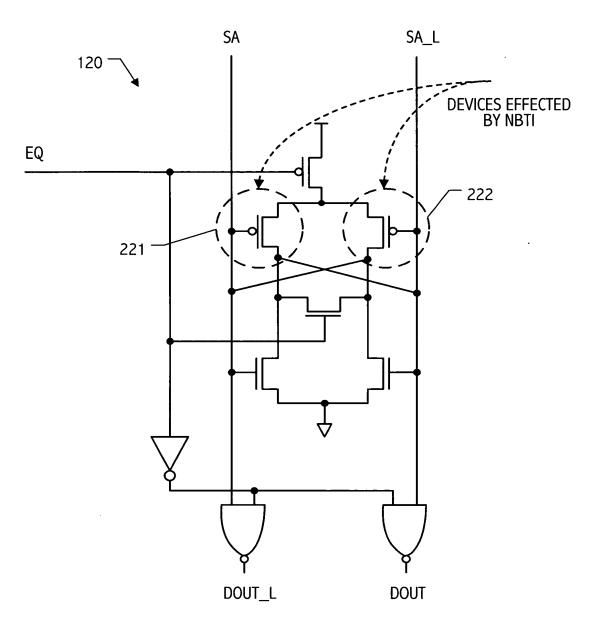


FIG. 2

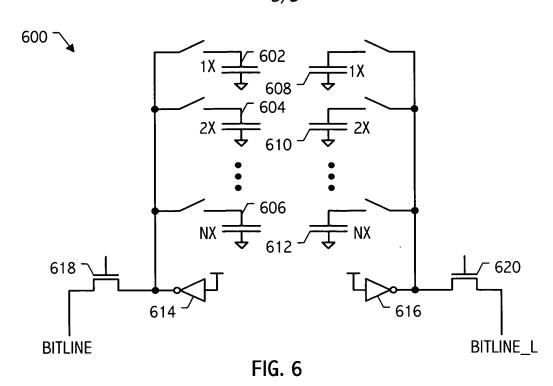
# REPLACEMENT SHEET TEST CIRCUIT FOR MEASURING SENSE AMPLIFIER AND MEMORY MISMATCHES Eleyan et al. Attorney Docket: 004-30059

3/5 300 **TEST BLOCK** 302 BITLINE BITLINE\_L **MEMORY COLUMN** 304 BITLINE BITLINE\_L COLUMN SELECT/DECODE 306 CONTROL **BLOCK** 308 SA SA\_L SENSE AMP 120 EQ 222 221 DOUT\_L DOUT

FIG. 3

# REPLACEMENT SHEET TEST CIRCUIT FOR MEASURING SENSE AMPLIFIER AND MEMORY MISMATCHES Eleyan et al.

Attorney Docket: 004-30059



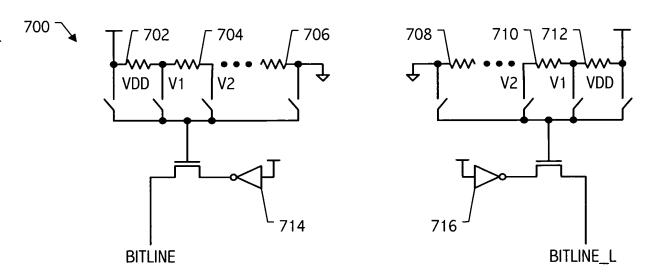


FIG. 7

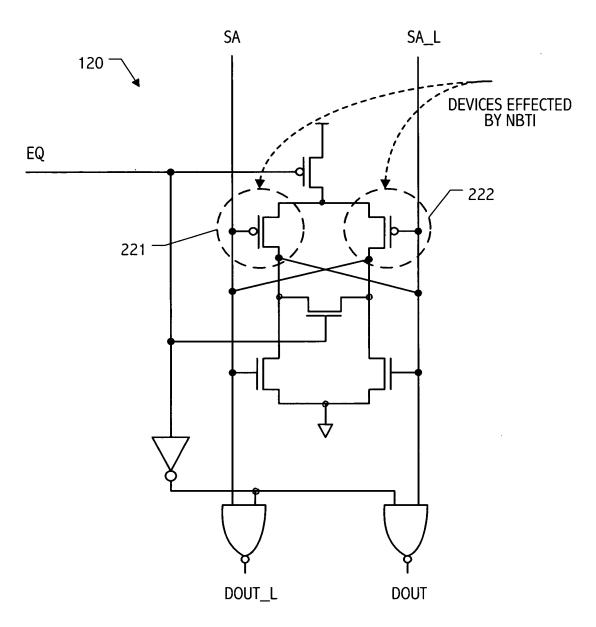


FIG. 2

## ANNOTATED MARKED-UP DRAWINGS TEST CIRCUIT FOR MEASURING SENSE AMPLIFIER AND MEMORY MISMATCHES Eleyan et al.

Attomey Docket: 004-30059

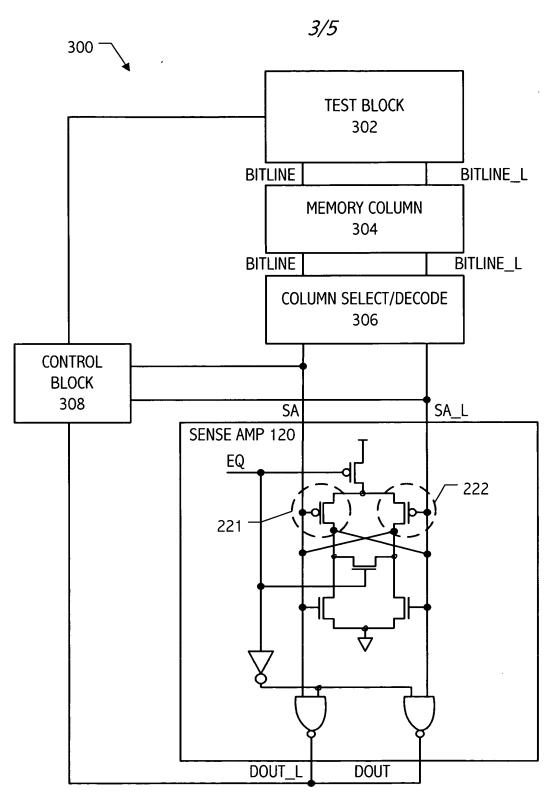
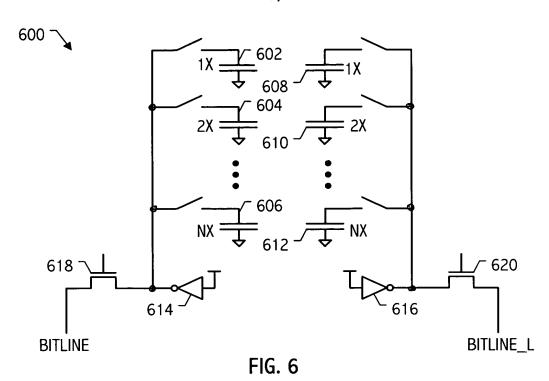
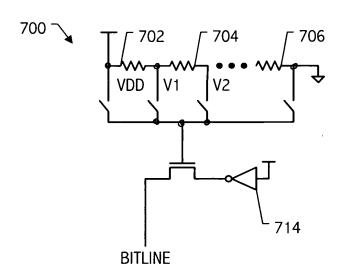


FIG. 3

## ANNOTATED MARKED-UP DRAWINGS TEST CIRCUIT FOR MEASURING SENSE AMPLIFIER AND MEMORY MISMATCHES Eleyan et al.

Attorney Docket: 004-30059





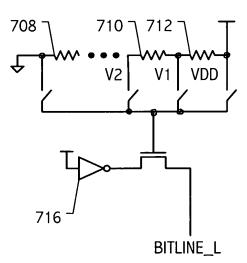


FIG. 7